Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,972	GABE ET AL.	
Examiner	Art Unit	_
Laio 7hana	4740	

SEARCHED				
Class	Subclass	Date	Examiner	
204	242	5/24/2006	LLZ	
106	1.12	5/24/2006	LLZ	
106	1.13	5/24/2006	LLZ	
106	1.14	5/24/2006	LLZ	
106	1.15	5/24/2006	LLZ	
106	1.18	5/24/2006	LLZ	
106	1.19	5/24/2006	LLZ	
106	1.21	5/24/2006	LLZ	
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205	297-298	5/24/2006	· LLZ	

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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	DATE	EXMR
Inventorship Search	5/24/2006	LLZ
EAST Search	5/24/2006	LLZ